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Application/Control No.	Applicant(s)/Patent unde Reexamination		
09/764,044	BREYMEIER ET AL.	T AL.	
Examiner	Art Unit		
Dustin Nguyen	2154		

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Class	Subclass	Date	Examiner
715	501	5/2/2006	DN

INI	NTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
search EAST, inventors search	5/2/2006	DN		
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